

Notice of References Cited	Application/Control No. 10/700,820	Applicant(s)/Patent Under Reexamination BENNETT ET AL.	
	Examiner Tadesse Hailu	Art Unit 2173	Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,661,431	12-2003	Stuart et al.	715/733
*	B	US-6,112,238	08-2000	Boyd et al.	709/224
*	C	US-6,963,874	11-2005	Kasriel et al.	707/10
*	D	US-6,816,903	11-2004	Rakoshitz et al.	709/226
*	E	US-6,393,479	05-2002	Glommen et al.	709/224
*	F	US-2005/0188008	08-2005	Weissman, Boris	709/203
*	G	US-2002/0063735	05-2002	Tamir et al.	345/745
*	H	US-2002/0046281	04-2002	Cope, Brian Charles	709/227
*	I	US-2002/0156552	10-2002	Whiting, Jon	700/300
*	J	US-2002/0194329	12-2002	Alling, Eric R.	709/224
*	K	US-2003/0084142	05-2003	Casati et al.	709/224
*	L	US-2003/0018450	01-2003	Carley, Stephen	702/179
*	M	US-2005/0021731	01-2005	Sehm et al.	709/224

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited

Application/Control No.

10/700,820

Applicant(s)/Patent Under
Reexamination
BENNETT ET AL.

Examiner

Tadesse Hailu

Art Unit

2173

Page 2 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0046281	04-2002	Cope, Brian Charles	709/227
*	B	US-2002/0147772	10-2002	Glommen et al.	709/203
*	C	US-2004/0267612	12-2004	Veach, Eric	705/014
*	D	US-2004/0225562	11-2004	Turner, Brenton Russell	705/014
*	E	US-6,973,490	12-2005	Robertson et al.	709/224
*	F	US-5,819,285	10-1998	Damico et al.	707/104.1
*	G	US-5,664,105	09-1997	Keisling et al.	709/224
*	H	US-6,839,680	01-2005	Liu et al.	705/10
*	I	US-2004/0174397	09-2004	Cereghini et al.	345/855
*	J	US-2004/0249650	12-2004	Freedman et al.	705/001
*	K	US-2002/0111838	08-2002	Welbourne, Theresa M.	705/7
*	L	US-6,963,874	11-2005	Kasriel et al.	707/10
*	M	US-7,143,365	11-2006	Gallella, Ron M.	715/851

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/700,820	Applicant(s)/Patent Under Reexamination BENNETT ET AL.	
	Examiner Tadesse Hailu	Art Unit 2173	Page 3 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,741,990	05-2004	Nair et al.	707/9
*	B	US-2005/0097204	05-2005	Horowitz et al.	709/223
*	C	US-2002/0186237	12-2002	Bradley et al.	345/736
*	D	US-2005/0188318	08-2005	Tamir et al.	715/744
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.